- Flow-Through Architecture Optimizes **PCB** Layout
- Center-Pin V_{CC} and GND Pin Configurations **Minimize High-Speed Switching Noise**
- **EPIC[™]** (Enhanced-Performance Implanted CMOS) 1-µm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic **Small-Outline Packages and Standard** Plastic 300-mil DIPs

description

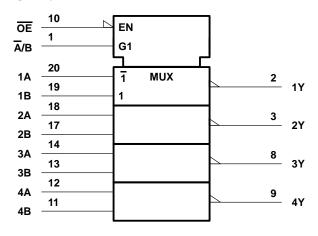
This data selector/multiplexer contains inverters and drivers to supply full data selection to the four output gates. A separate output-enable (OE) input is provided. A 4-bit word is selected from one of two sources and is routed to the four outputs. The 74AC11158 provides true data.

The 74AC11158 is characterized for operation from -40°C to 85°C.

FUNC	τιονι	TARI	F
1 0110	11014		

	INPU	OUTPUT		
OE	A/B	Α	В	Y
н	Х	Х	Х	Н
L	L	L	х	н
L	L	Н	х	L
L	н	Х	L	н
L	Н	Х	Н	L

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

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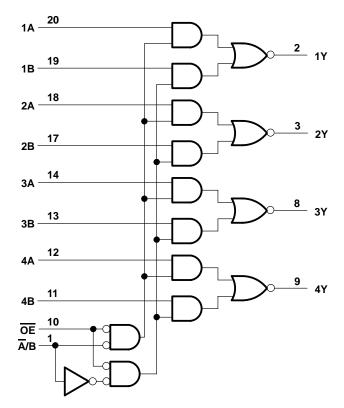
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



DW	DW OR N PACKAGE (TOP VIEW)							
Ā/B		20] 1A					
1Y [2	19]1B					
2Y [3	18] 2A					
GND [4	17] 2B					
GND [5	16] V _{CC}					
GND [6	15] V _{CC}					
GND [7	14] 3A					
3Y [8	13] 3B					
4Y [9	12] 4A					
OE [10	11] 4B					

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logic diagram (positive logic)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (see Note 1)	-0.5 V to V _{CC} + 0.5 V
Output voltage range, V _O (see Note 1)	-0.5 V to V _{CC} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Storage temperature range	−65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

recommended operating conditions (see Note 2)

			MIN	NOM	MAX	UNIT
VCC	Supply voltage		3	5	5.5	V
		$V_{CC} = 3 V$	2.1			
VIH	High-level input voltage	$V_{CC} = 4.5 V$	3.15			V
		$V_{CC} = 5.5 V$	3.85			
		$V_{CC} = 3 V$			0.9	
VIL	Low-level input voltage	$V_{CC} = 4.5 V$			1.35	V
		V _{CC} = 5.5 V			1.65	
Vj	Input voltage		0		VCC	V
VO	Output voltage		0		VCC	V
		V _{CC} = 3 V			-4	
ЮН	High-level output current	$V_{CC} = 4.5 V$			-24	mA
		$V_{CC} = 5.5 V$			-24	
		$V_{CC} = 3 V$			12	
IOL	Low-level output current	$V_{CC} = 4.5 V$			24	mA
		V _{CC} = 5.5 V			24	
A #/ A	longit transition rise or fall rate	Ā/B	0		5	ma/\/
$\Delta t / \Delta v$	Input transition rise or fall rate	Except A/B	0		10	ns/V
Т _А	Operating free-air temperature		-40		85	°C

NOTE 2: Unused or floating inputs must be held high or low.



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PARAMETER	TEST CONDITIONS	N	TA = 25°C			MAINI		INUT
FARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
	$I_{OH} = -50 \ \mu A$ $I_{OH} = -4 \ m A$	3 V	2.9			2.9		
		4.5 V	4.4			4.4		
		5.5 V	5.4			5.4		
VOH		3 V	2.58			2.48		V
	I _{OL} = - 24 mA	4.5 V	3.94			3.8		
		5.5 V	4.94			4.8		
	$I_{OH} = -75 \text{ mA}^{\dagger}$	5.5 V				3.85		
	I _{OL} = 50 μA	3 V			0.1		0.1	
		4.5 V			0.1		0.1	
		5.5 V			0.1		0.1	
VOL	I _{OL} = 12 mA	3 V			0.36		0.44	V
	I _{OL} = 24 mA I _{OL} = 75 mA [†]	4.5 V			0.36		0.44	
		5.5 V			0.36		0.44	
		5.5 V					1.65	
Ц	$V_I = V_{CC} \text{ or } GND$	5.5 V			±0.1		±1	μΑ
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			8		80	μΑ
Ci	V _I = V _{CC} or GND	5 V		4				pF

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	ТО	T _A = 25°C			MIN	МАХ	UNIT
FARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX		INIAA	
^t PLH	A or B	V	1.5	5.8	8.3	1.5	9	ns
^t PHL		Ι	1.5	5.9	8.6	1.5	9.4	115
^t PLH	Ā/B	V	1.5	6.5	9	1.5	9.8	ns
^t PHL		Ι	1.5	6.8	9.4	1.5	10.3	115
^t PLH	OE	V	1.5	5.7	8.1	1.5	9	ns
^t PHL	UE	I	1.5	6.3	8.8	1.5	9.7	115

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C			MIN	мах	UNIT
FARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	WIIIN		UNIT
^t PLH	A or B	v	1.5	3.6	6.4	1.5	6.8	
^t PHL		Τ	1.5	3.9	6.6	1.5	7.4	ns
^t PLH	Ā/B	V	1.5	4.1	6.9	1.5	7.4	ns
^t PHL	A/B	Ι	1.5	4.9	7.2	1.5	7.9	115
^t PLH	OE	V	1.5	3.7	6.4	1.5	6.9	ns
^t PHL	UE	I I	1.5	4.2	6.9	1.5	7.5	115

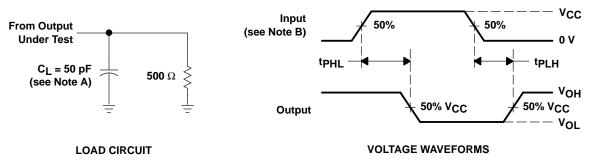


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operating characteristics, V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	$C_L = 50 \text{ pF}, \text{ f} = 1 \text{ MHz}$	33	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f = 3 ns, t_f = 3 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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